

K3430-VB Datasheet N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY		
V _{DS}	40	V
$R_{DS(on)}$ $V_{GS} = 10$ V	6	mΩ
I _D	110	А
Configuration	Sin	gle

0

GDS

Top View

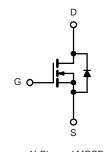
TO-220AB

FEATURES

- TrenchFET[®] Power MOSFET
- 100 % $\rm R_g$ and UIS Tested

APPLICATIONS

- Synchronous Rectification
- Power Supplies



N-Channel MOSFET

ABSOLUTE MAXIMUM RATING				
Parameter		Symbol	Limit	Unit
Drain-Source Voltage Gate-Source Voltage		V _{DS}	40	V
		V _{GS}	± 20	v
	T _C = 25 °C		110 ^{a, c}	
Continuous Droin Current (T $= 175$ °C)	T _C = 70 °C		90 ^c	
Continuous Drain Current (T _J = 175 °C)	T _A = 25 °C	I _D	31 ^b	A
	T _A = 70 °C		25 ^b	A
Pulsed Drain Current		I _{DM}	270	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	85	
Single Pulse Avalanche Energy		E _{AS}	320	V
Continuous Source Drain Diade Current	T _C = 25 °C	I _S	110 ^{a, c}	A
Continuous Source-Drain Diode Current	T _A = 25 °C	IS	2.6 ^b	- A
	T _C = 25 °C		312 ^a	
Maximum Power Dissipation	T _C = 70 °C	P _D	200	w
	T _A = 25 °C	۲D	3.13 ^b	VV
	T _A = 70 °C		2.0 ^b	
Operating Junction and Storage Temperature Ra	ange	T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	32	40	°C/W
Maximum Junction-to-Case	Steady State	R _{thJC}	0.33	0.4	0,00

Notes:

a. Based on T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. Calculated based on maximum junction temperature. Package limitation current is 110 A.

SPECIFICATIONS $T_J = 25 \ ^{\circ}C$, $T_J = 25 \ ^{\circ}C$	unless other	wise noted				
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				_		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	40			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Ι _D = 250 μΑ		41		mV/°
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1β = 200 μΛ		- 8		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.2		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zara Cata Valtaga Drain Current	 	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$	1		1	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	120			A
	D	V _{GS} = 10 V, I _D = 30 A		6		_
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 20 \text{ A}$		7		- mΩ
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A		180		S
Dynamic ^b	•				•	•
Input Capacitance	C _{iss}			2900		pF
Output Capacitance	C _{oss}	V_{DS} = 20 V, V_{GS} = 0 V, f = 1 MHz		750		
Reverse Transfer Capacitance	C _{rss}			310		
Total Gate Charge	Qg			130		
Gate-Source Charge	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		20		nC
Gate-Drain Charge	Q _{gd}			32		
Gate Resistance	Rg	f = 1 MHz		0.85	1.3	Ω
Turn-On Delay Time	t _{d(on)}			20	30	
Rise Time	t _r	V_{DD} = 20 V, R_L = 1.0 Ω		11	17	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20$ Å, $V_{GEN} = 10$ V, $R_g = 1$ Ω		77	115	1
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}			102	155	- ns - -
Rise Time	t _r	$V_{DD} = 20 \text{ V}, \text{ R}_1 = 1.0 \Omega$		62	95	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20$ A, V_{GEN} = 4.5 V, R_g = 1 Ω		180	270	
Fall Time	t _f			60	90	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			110	A
Pulse Diode Forward Current ^a	I _{SM}				200	A
Body Diode Voltage	V _{SD}	I _S = 20 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			50	75	ns
Body Diode Reverse Recovery Charge	Q _{rr}	L = 20.4 di/dt = 100.4 from T = 25.90		70	105	nC
Reverse Recovery Fall Time	ta	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		30		
Reverse Recovery Rise Time	t _b			20		ns

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

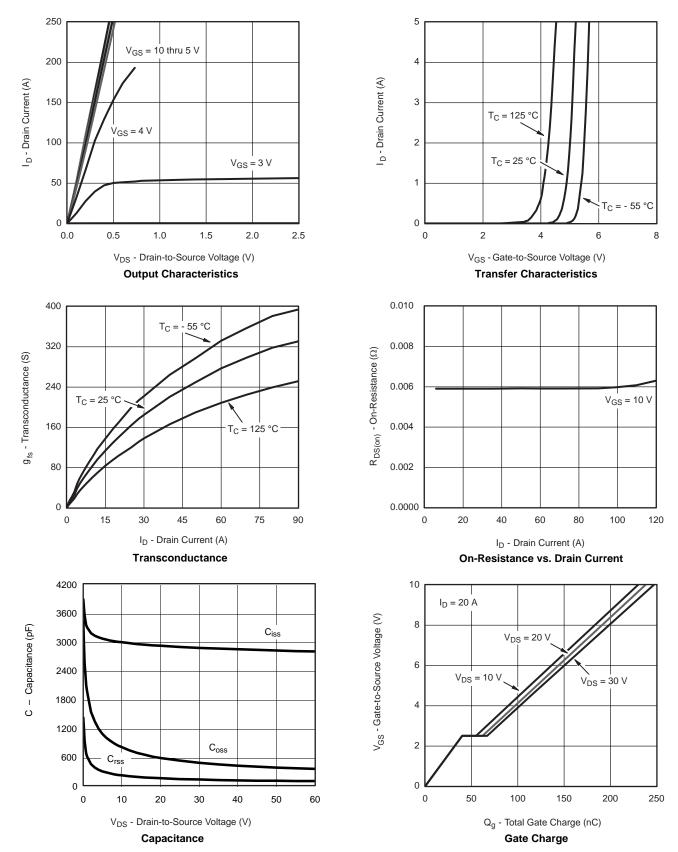
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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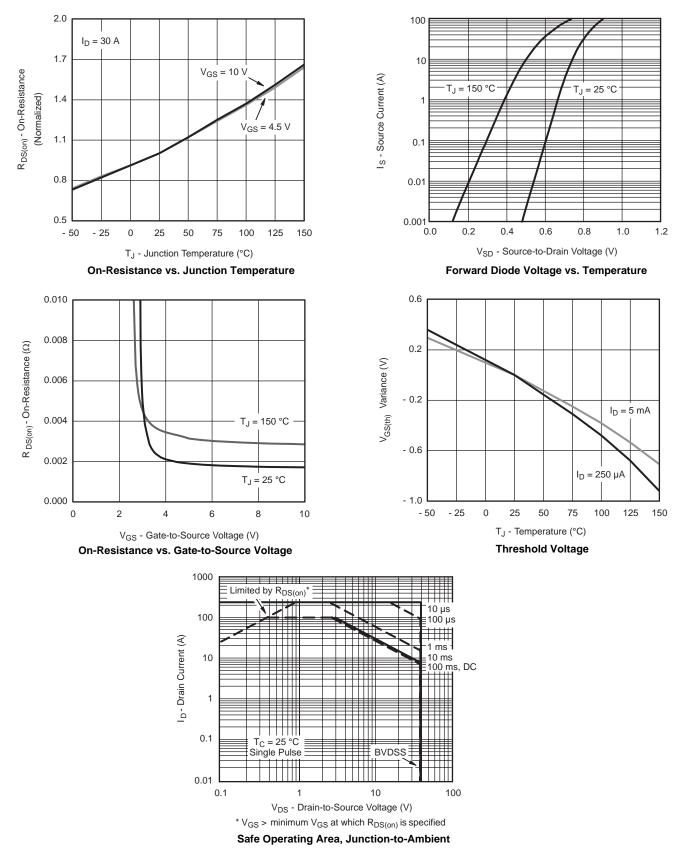
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

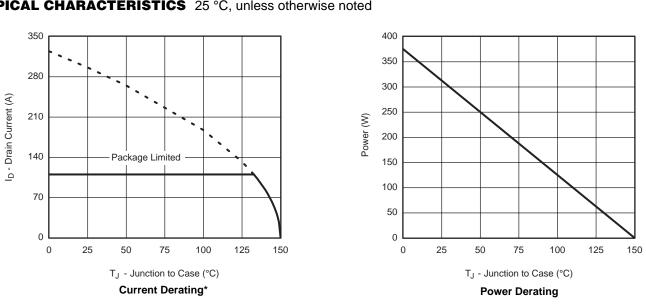


服务热线:400-655-8788



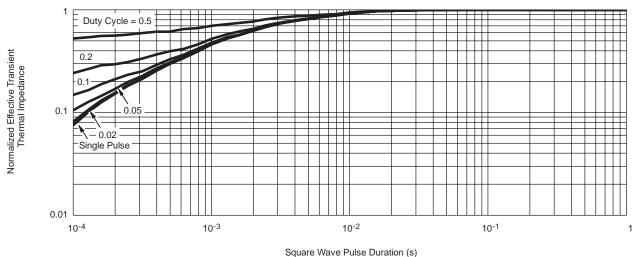
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* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

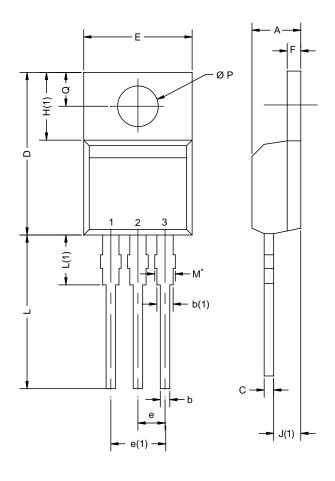


Normalized Thermal Transient Impedance, Junction-to-Case

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MIN.	MAX.		
		MIN.	MAX.
4.25	4.65	0.167	0.183
0.69	1.01	0.027	0.040
1.20	1.73	0.047	0.068
0.36	0.61	0.014	0.024
14.85	15.49	0.585	0.610
10.04	10.51	0.395	0.414
2.41	2.67	0.095	0.105
4.88	5.28	0.192	0.208
1.14	1.40	0.045	0.055
6.09	6.48	0.240	0.255
2.41	2.92	0.095	0.115
13.35	14.02	0.526	0.552
3.32	3.82	0.131	0.150
3.54	3.94	0.139	0.155
2.60	3.00	0.102	0.118
	1.20 0.36 14.85 10.04 2.41 4.88 1.14 6.09 2.41 13.35 3.32 3.54 2.60	1.20 1.73 0.36 0.61 14.85 15.49 10.04 10.51 2.41 2.67 4.88 5.28 1.14 1.40 6.09 6.48 2.41 2.92 13.35 14.02 3.32 3.82 3.54 3.94	1.20 1.73 0.047 0.36 0.61 0.014 14.85 15.49 0.585 10.04 10.51 0.395 2.41 2.67 0.095 4.88 5.28 0.192 1.14 1.40 0.045 6.09 6.48 0.240 2.41 2.92 0.095 13.35 14.02 0.526 3.32 3.82 0.131 3.54 3.94 0.139 2.60 3.00 0.102

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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